PCN Number:		20	20140930003A							PCN Date:		12/04/2014
Title:Qualification of Amkor Philippines as an Additional Assembly and Test location for Select Devices in the SOIC package												
Customer Contact:		PCI	PCN Manager		Ρ	hone:	+1(214)48	+1(214)480-6037				ality rvices
Proposed 1 st Ship Da		ite:	te: 03/04/2015			Estim	ated Sample Availa			ability: Date provided upon request		
Change Type:												
Assembly Site			Assembly Process			\boxtimes	Asse	embly Ma	teria	ls		
Design				Electrical Specification				Mec	hanical S	pecif	ication	
Test Site				Packing/Shipping/Labeling				Test	est Process			
Wafer Bump Site				Wafer Bump Material				Waf	afer Bump Process			
Wafe	Wafer Fab Site			Wafer Fab Materials			5		Waf	Vafer Fab Process		
				Part number change								
					P	CN De	tails					
Descript	ion of Chang	ie:			-							
notification. The additional device are highlighted and bolded in the device list below. The expected first shipment date for these new devices will be 90 days from this notice for these newly added devices only. The retracted devices are highlighted bolded , and struck through in the device list below. Texas Instruments is pleased to announce the qualification of Amkor Philippines as an additional Assembly and Test location for the devices listed below.												
		_				SEH				<mark>ikor Phi</mark>		
Mount Compound			SID#EY1000063				SID#101374994					
Mold Compound SI			SID#	EN	EN2000509 SID			D#101379294				
Test coverage, insertions, conditions will remain consistent with current testing and verified with test MQ.												
Reason for Change:												
Continuity of Supply												
Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative):												
None												
Changes to product identification resulting from this PCN:												
Assemb	Assembly Site											
ASE Shanghai			Assembly Site Origin (22				(22L) ASO: ASH				
AMKOR	AMKOR (AP1)			Assembly Site Origin (22				2L) ASO: AKR				

Sample product shipping label (not actual product label)

TEXAS INSTRUMENTS 20: MADE IN: Malaysia 20: MSL '2 /260C/1 YEAR SEAL DT MSL 1 /235C/UNLIM 03/29/04 OPT: ITEM: 39 LBL: 5A (L)T0:1750 (1P) SN74LS07NSR (Q) 2000 (D) 0336 (31T) LOT: 3959047MLA (4W) TKY (1T) 7523483S12 (P) (2P) REV: (V) 0033317 (20L) CS0: SHE (21L) CC0:USA (2L) AS0: MLA (23L) ACO: MYS						
Topside Device marking: Assembly site code for ASH = A Assembly site code for AKR = 4 Product Affected						
roduct Affected			Т Т			
	TPS54228DDA	TPS54332DDA	TPS54527DDAR			
905X5433200	TPS54228DDA TPS54228DDAR	TPS54332DDA TPS54332DDAR	TPS54527DDAR TPS54528DDA			
905X5433200 HPA01123DDAR						
905X5433200 HPA01123DDAR SN1101004DDAR	TPS54228DDAR	TPS54332DDAR	TPS54528DDA			
905X5433200 HPA01123DDAR 5N1101004DDAR 5N1101005DDAR	TPS54228DDAR TPS54229DDA	TPS54332DDAR TPS54335DDA	TPS54528DDA TPS54528DDAR			
905X5433200 HPA01123DDAR 5N1101004DDAR 5N1101005DDAR 5N1106041DDAR	TPS54228DDAR TPS54229DDA TPS54229DDAR	TPS54332DDAR TPS54335DDA TPS54335DDAR	TPS54528DDA TPS54528DDAR TPS54627DDA			
005X5433200 HPA01123DDAR SN1101004DDAR SN1101005DDAR SN1106041DDAR SN1110024DDAR	TPS54228DDAR TPS54229DDA TPS54229DDAR TPS54229EDDA	TPS54332DDAR TPS54335DDA TPS54335DDA TPS54335DDAR TPS54427DDA	TPS54528DDA TPS54528DDAR TPS54627DDA TPS54627DDAR			
005X5433200 HPA01123DDAR SN1101004DDAR SN1101005DDAR SN1106041DDAR SN1110024DDAR SN1208017DDAR	TPS54228DDAR TPS54229DDA TPS54229DDAR TPS54229EDDA TPS54229EDDAR TPS54229EDDAR	TPS54332DDAR TPS54335DDA TPS54335DDAR TPS54427DDA TPS54427DDAR	TPS54528DDA TPS54528DDAR TPS54627DDA TPS54627DDAR TPS54628DDA			
Product Affected 905X5433200 HPA01123DDAR SN1101004DDAR SN1101005DDAR SN1106041DDAR SN1106041DDAR SN110024DDAR SN1100024DDAR SN1208017DDAR SN54229EDDAR TPS54227DDA	TPS54228DDAR TPS54229DDA TPS54229DDAR TPS54229EDDA TPS54229EDDAR TPS54229EDDAR TPS5432DDA	TPS54332DDAR TPS54335DDA TPS54335DDAR TPS54427DDA TPS54427DDA TPS54428DDA	TPS54528DDA TPS54528DDAR TPS54627DDA TPS54627DDAR TPS54628DDA TPS54628DDA TPS54628DDAR			

Qualification Report

Amkor: Qualify Amkor Assembly (AP1) with 101379294 mold compound, 101374994 mount compound + Cu wire (2.0 MIL) on PWR DCS SOIC devices with BOAC Approval 09/18/2014

Product Attributes

Attributes	Qual Device: TPS54327DDA	Qual Device: TPS54627DDA
Assembly Site	AMKOR AP1	AMKOR AP1
Package Family	SOIC	SOIC
Flammability Rating	UL 94 V-0	UL 94 V-0
Wafer Fab Site	RFAB	RFAB
Wafer Fab Process	LBC7	LBC7

- QBS: Qual By Similarity

- Qual Devices qualified at LEVEL2-260C: TPS54327DDA, TPS54627DDA

Qualification Results

Туре	Test Name / Condition	Duration	Qual Device: TPS54327DDA	Qual Device: TPS54627DDA
THB	Biased Temperature and Humidity, 85C/85%RH	1000 Hours	3/231/0	-
AC	Autoclave 121C	96 Hours	3/231/0	3/231/0
ТС-ВР	Auto Post Temp. Cycle Bond Pull	per MIL-STD 883 Method 2011	3/15/0	3/15/0
TC	Temperature Cycle, -65/150C	500 Cycles	3/231/0	3/231/0
HTSL	High Temp Storage Bake 170C	420 Hours	3/229/0	-
ED	Electrical Characterization.	Per Datasheet Parameters	1/30/0	-
FLAM	Flammability (UL 94V-0)		3/15/0	-

Data Displayed as: Number of lots / Total sample size / Total failed

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours - The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Pb-free Status:

Qualified Pb-Free(SMT) and Green

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
Japan	PCNJapanContact@list.ti.com